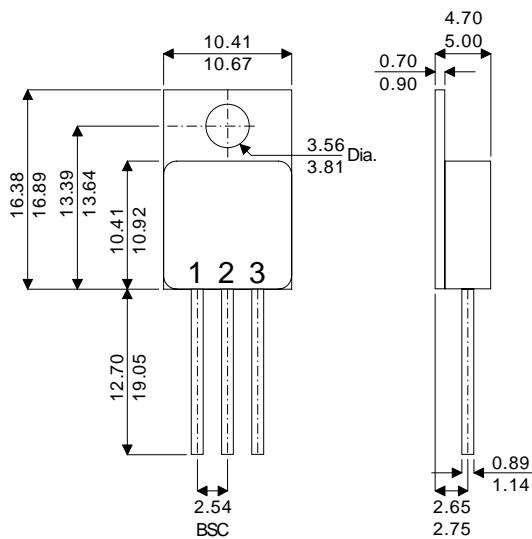


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### MECHANICAL DATA

Dimensions in mm (inches)



### TO-220M – Metal Package

Pad 1 – Gate

Pad 2 – Drain

Pad 3 – Source

## N-CHANNEL POWER MOSFET FOR HI-REL APPLICATIONS

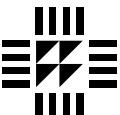
$V_{DSS}$	100V
$I_{D(\text{cont})}$	7.3A
$R_{DS(\text{on})}$	0.31Ω

### FEATURES

- HERMETICALLY SEALED TO-220 METAL PACKAGE
- SIMPLE DRIVE REQUIREMENTS
- LIGHTWEIGHT
- SCREENING OPTIONS AVAILABLE
- ALL LEADS ISOLATED FROM CASE

### ABSOLUTE MAXIMUM RATINGS ( $T_{\text{case}} = 25^\circ\text{C}$ unless otherwise stated)

$V_{GS}$	Gate – Source Voltage	$\pm 20\text{V}$
$I_D$	Continuous Drain Current @ $T_{\text{case}} = 25^\circ\text{C}$	7.3A
$I_D$	Continuous Drain Current @ $T_{\text{case}} = 100^\circ\text{C}$	4.6A
$I_{DM}$	Pulsed Drain Current	29A
$P_D$	Power Dissipation @ $T_{\text{case}} = 25^\circ\text{C}$	30W
	Linear Derating Factor	0.24W/ $^\circ\text{C}$
$T_J, T_{\text{stg}}$	Operating and Storage Temperature Range	-55 to $150^\circ\text{C}$
$R_{\theta\text{JC}}$	Thermal Resistance Junction to Case	$4.1^\circ\text{C/W}$ max.
$R_{\theta\text{JA}}$	Thermal Resistance Junction to Ambient	$80^\circ\text{C/W}$ max.



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**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>STATIC ELECTRICAL RATINGS</b>					
$\text{BV}_{\text{DSS}}$	Drain – Source Breakdown Voltage $V_{\text{GS}} = 0$ $I_D = 1\text{mA}$	100			V
$\Delta \text{BV}_{\text{DSS}}$	Temperature Coefficient of $\Delta T_J$ Breakdown Voltage Reference to $25^\circ\text{C}$ $I_D = 1\text{mA}$		0.1		$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{on})}$	Static Drain – Source On-State Resistance $V_{\text{GS}} = 10\text{V}$ $I_D = 4.6\text{A}$		0.31		$\Omega$
	$V_{\text{GS}} = 10\text{V}$ $I_D = 7.3\text{A}$		0.36		
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage $V_{\text{DS}} = V_{\text{GS}}$ $I_D = 250\mu\text{A}$	2		4	V
$g_{\text{fs}}$	Forward Transconductance $V_{\text{DS}} \geq 15\text{V}$ $I_{\text{DS}} = 4.6\text{A}$	1.5			$\text{S}(\text{O})$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current $V_{\text{GS}} = 0$ $V_{\text{DS}} = 0.8\text{BV}_{\text{DSS}}$			25	$\mu\text{A}$
	$T_J = 125^\circ\text{C}$			250	
$I_{\text{GSS}}$	Forward Gate – Source Leakage $V_{\text{GS}} = 20\text{V}$			100	nA
$I_{\text{GSS}}$	Reverse Gate – Source Leakage $V_{\text{GS}} = -20\text{V}$			-100	
<b>DYNAMIC CHARACTERISTICS</b>					
$C_{\text{iss}}$	Input Capacitance $V_{\text{GS}} = 0$		350		pF
$C_{\text{oss}}$	Output Capacitance $V_{\text{DS}} = 25\text{V}$		150		
$C_{\text{rss}}$	Reverse Transfer Capacitance $f = 1\text{MHz}$		24		
$Q_g$	Total Gate Charge $V_{\text{GS}} = 10\text{V}$ $I_D = 7.3\text{A}$ $V_{\text{DS}} = 0.5\text{BV}_{\text{DSS}}$	7.7		17	nC
$Q_{\text{gs}}$	Gate – Source Charge $I_D = 7.3\text{A}$	0.7		4	nC
$Q_{\text{gd}}$	Gate – Drain ("Miller") Charge $V_{\text{DS}} = 0.5\text{BV}_{\text{DSS}}$	2		8	
$t_{\text{d}(\text{on})}$	Turn-On Delay Time $V_{\text{DD}} = 50\text{V}$			15	ns
$t_r$	Rise Time $I_D = 7.3\text{A}$			70	
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time $R_G = 7.5\Omega$			40	
$t_f$	Fall Time			70	
<b>SOURCE – DRAIN DIODE CHARACTERISTICS</b>					
$I_S$	Continuous Source Current			7.3	A
$I_{\text{SM}}$	Pulse Source Current			29	
$V_{\text{SD}}$	Diode Forward Voltage $I_S = 7.3\text{A}$ $T_J = 25^\circ\text{C}$ $V_{\text{GS}} = 0$			1.8	V
$t_{\text{rr}}$	Reverse Recovery Time $I_S = 7.3\text{A}$ $T_J = 25^\circ\text{C}$			240	ns
$Q_{\text{rr}}$	Reverse Recovery Charge $d_i / d_t \leq 100\text{A}/\mu\text{s}$ $V_{\text{DD}} \leq 50\text{V}$			2	$\mu\text{C}$
<b>PACKAGE CHARACTERISTICS</b>					
$L_D$	Internal Drain Inductance (from 6mm down drain lead pad to centre of die)		8.7		nH
$L_S$	Internal Source Inductance (from 6mm down source lead to centre of source bond pad)		8.7		